

Notice of References Cited	Application/Control No. 10/510,343	Applicant(s)/Patent Under Reexamination TAKAMURA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0027033	02-2003	Seabaugh et al.	429/40
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2005053763	03-2005	JP (Eng. Ab.)		
	O	JP 2005281086	10-2005	JP (Eng. Ab.)		
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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